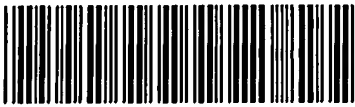


<b>Search Notes</b>  	<b>Application/Control No.</b>  10777730	<b>Applicant(s)/Patent Under Reexamination</b>  KIM, DOHEON
	<b>Examiner</b>  Keefer, Michael E	<b>Art Unit</b>  2154

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	224	8/27/20074	MEK

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST Search	8/24/2007	MEK
Consulted Examiner Dustin Nguyen	8/24/2007	MEK
Google Search	8/27/2007	MEK

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>